

| | | | | |
|-----------------------------------|---------------------------------------|--|---|-------------|
| Notice of References Cited | Application/Control No. 09/729,694 | | Applicant(s)/Patent Under Reexamination YANG ET AL. | |
| | Examiner Sudhanshu C. Pathak | | Art Unit 2634 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| | A | US-5,952,963 | 09-1999 | Shen et al. | 342/367 |
| | B | US-6,826,718 | 11-2004 | Wu, Chuyun | 714/46 |
| | C | US-6,393,277 | 05-2002 | Sahin et al. | 455/423 |
| | D | US-6,285,875 | 09-2001 | Alajoki et al. | 455/423 |
| | E | US-5,987,306 | 11-1999 | Nilsen et al. | 455/67.11 |
| | F | US-5,490,285 | 02-1996 | Ahlenius et al. | 455/446 |
| | G | US-6,469,984 | 10-2002 | Baker, Kenneth R. | 370/232 |
| | H | US-5,960,353 | 09-1999 | Lee, David Y. | 455/453 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.